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Sheet 1 of 2

Applicant:

Walker, et al.

Serial No.:

10/721,147

Att'y Docket No.: 11675.102.2

Filing Date:

November 25, 2003

Art Unit: 2814 2822

For:

SACRIFICIAL SELF-ALIGNED INTERCONNECT
STRUCTURE AND METHOD OF MAKING



INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT

U.S. Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Issue Date</u>	<u>Name</u>
MAT 1	4,855,952	08/08/89	Kiyosumi
2	5,077,688	12/31/91	Kumanoya, et al.
3	5,120,677	06/09/92	Wakamatsu
4	5,286,344	02/15/94	Blalock, et al.
5	5,343,354	08/30/94	Lee, et al.
6	5,389,559	02/14/95	Hsieh, et al.
7	5,395,786	03/07/95	Hsu, et al.
8	5,429,978	07/04/95	Lu, et al.
9	5,594,682	01/14/97	Lu, et al.
10	5,763,931	06/09/98	Sygiyama
11	5,795,804	08/18/98	Jenq
12	5,811,283	09/22/98	Sun
13	5,827,765	10/27/98	Stengl, et al.
MAT 14	5,981,330	11/09/99	Jenq

Examiner: Michael Trinh Date Considered: 4/26/05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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OTHER DOCUMENTS

MJ 15

Nesbit et al., "A 0.6 um² 256 Mb Trench DRAM Cell With Self-Aligned Buried STrap (BEST)", IEDM 93-627, pp. 26.2.1-26.2.4, 0-7803-1450-6 1993 IEEE

References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

Examiners will consider all citations submitted in conformance with 37 C.F.R. § 1.98 and MPEP Sec. 609 and place their initials adjacent the citations in the spaces provided on this form. Examiners will also initial citations not in conformance with the guidelines which may have been considered. A reference may be considered by the Examiner for any reason whether or not the citation is in full conformance with the guidelines. A line will be drawn through a citation if it is not in conformance with the guidelines AND has not been considered. A copy of the submitted form, as reviewed by the Examiner, will be returned to the applicant with the next communication. The original of the form will be entered into the application file.

Each citation initialed by the Examiner will be printed on the issued patent in the same manner as references cited by the Examiner on Form PTO-892.

The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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Examiner: Michael Trinh Date Considered: 4/26/05

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